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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

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In re application of: Satya et al.

Attorney Docket No.: KLA1P016G

Application No.: Unassigned

Examiner: Unassigned

Filed: Herewith

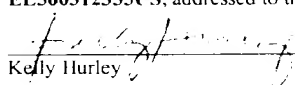
Group: Unassigned

Title: MULTI-PIXEL METHODS AND  
APPARATUS FOR ANALYSIS OF DEFECT  
INFORMATION FROM TEST STRUCTURES ON  
SEMICONDUCTOR DEVICES

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**CERTIFICATE OF EXPRESS MAILING**

I hereby certify that this paper and the documents and/or fees referred to as attached therein are being deposited with the United States Postal Service on August 25, 2000 in an envelope as "Express Mail Post Office to Addressee" service under 37 CFR §1.10, Mailing Label Number **EL560312335US**, addressed to the Assistant Commissioner for Patents, Washington, DC 20231.

  
Kelly Hurley**PRELIMINARY AMENDMENT A**

Assistant Commissioner for Patents  
Washington, D.C. 20231

Dear Sir:

Prior to an examination on the merits, please enter the following amendments:

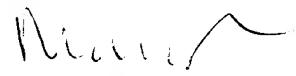
**In Cross-Reference to Related Patent Application:**

Please add -- This application claims the benefit of U.S. Provisional Application No. 60/170,655 filed on December 14, 1999, the disclosure of which is incorporated herein by reference. -- before the sentence "This application claims the benefit of U.S. Provisional Application No. 60/198,339, filed on April 18, 2000, the disclosure of which is incorporated herein by reference."

**REMARKS**

Should the Examiner believe that a telephone conference would expedite the prosecution of this application, the undersigned can be reached at the telephone number set out below.

Respectfully submitted,  
BEYER WEAVER & THOMAS, LLP

  
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